

Agilent E6890A General Purpose Application

For the E6601A Wireless Communications Test Set

Data Sheet



The next generation of mobile phone manufacturing test.

The E6601A is the newest test set from Agilent Technologies, designed especially for high-volume, test-mode manufacturing. Combining industry-leading measurement speed, selectable formats, flexible licensing, and an integrated open Windows[®] XP PC, the E6601A helps you achieve the lowest cost of test in mobile phone manufacturing.

The E6601A and its available technology-specific software applications deliver industry leading measurement speed and accuracy for your mobile phone test needs.

The Agilent E6890A General Purpose Application is a software application program for the Agilent E6601A. It provides general measurement capability in the E6601A manufacturing test. The E6890A General Purpose Application is required to run technology-specific calibration applications.

E6601A/E6890A Features and General Specifications

- · CW, AM, FM, DSB-SC source modulation
- RF analyzer
- · Spectrum monitor
- Transmitter power measurements
- Power versus time measurement
- Frequency error measurement
- **QPSK EVM** measurement
- Optional IQ capture waveform sampling
- Internal OCXO timebase
- Built-in open Windows XP PC
- · Built-in help system
- Run test programs with internal or external PC
- GPIB, USB, and LAN connectivity and control





Technical Specifications

These specifications apply to an E6601A mainframe and the E6890A General Purpose Application firmware revision A.04 or higher. Specifications describe the test set's warranted performance and are valid for the unit's operation within ± 10 °C of the last self alignment. All specifications are valid after a 30-minute warm-up period of continuous operation with valid self-alignment unless otherwise noted. If the instrument has been off for longer than 48 hours, a 48-hour warm-up period followed by self-alignment is required.

Supplemental characteristics are intended to provide typical, but non-warranted, performance parameters that may be useful in applying the instrument. These characteristics are shown in italics and labeled as "typical." All units shipped from the factory meet these typical numbers at +25 °C ambient temperature without including measurement uncertainty.

CW RF Generator

Frequency

380 to 2700 MHz
Same as timebase accuracy
–130 to –13 dBm <i>typical over-range to –10 dBm</i>
–120 to –3 dBm <i>typical over-range to 0 dBm</i>
self alignment)
< ±1.0 dB, typically < ±0.5 dBm
< ±1.0 dB,
typically < ±0.5 dBm
0.01 dB
< +37 dBm (5 W) peak < +24 dBm (0.25 W) peak

Amplitude modulation

Modulation frequency range	100 Hz to 100 kHz
AM depth range	0 to 99.9%
AM accuracy	< ± 1.0% (20 kHz modulation frequency, 60% AM depth and –25 dBm output level)
Total harmonic distortion	< 0.5% (20 kHz modulation frequency, 60% AM depth and –25 dBm output level)

Frequency modulation

Modulation frequency range	10 Hz to 100 kHz	
FM deviation range	0 to 100 kHz	
FM deviation accuracy	< 3.5%	
Total harmonic distortion	< 0.5%	
Residual FM (0.3 - 3 kHz bandwith)		
RF frequencies	< 1 GHz to 5 Hz rms	
RF frequencies	2 to 2.2 GHz to 7 Hz rms	
RF frequencies	> 2.2 GHz to 9 Hz rms	

VSWR

RF IN/OUT	
380 to 1000 MHz	< 1.15:1
1000 to 2000 MHz	< 1.2:1
2000 to 2200 MHz	< 1.3:1
2200 to 2700 MHz	< 1.35:1
RF OUT ONLY	
380 to 1000 MHz	< 1.3:1
	1000 to 2700 MHz< 1.5:1

Spectral purity

Harmonics RF IN/OUT -130 to -15 dBm, 400 to 2200 MHz	< –30 dBc
RF OUT ONLY -120 to -5 dBm, 400 to 2200 MHz	<30 dBc
Non-harmonic spurious $(< \pm 10$ °C from last self alig	nment, 400 to 2200 MHz)

RF IN/OUT and RF OUT ONLY < -40 dBc, *typically* < -45 dBc

RF Analyzer

Frequency ranges

Cellular bands	411 to 486 MHz 776 to 960 MHz 1574 to 1577 MHz 1710 to 1980 MHz	IQ capture me Input level ran Average pov
General purpose	400 to 2000 MHz	Measurement
Input level ranges Average power Peak power	–65 to +33 dBm, <i>typical</i> over-range to +35 dBm –65 to +37 dBm (5 W)	1 kHz filter 30 kHz filter 100 kHz filte 300 kHz filte 640 kHz filte
Self alignment validity	$\leq \pm 10$ °C change and ≤ 30 days	1.23 MHz fil 1.6 MHz filte
VSWR RF IN/OUT 400 to 1000 MHz 1000 to 2000 MHz 2000 to 2200 MHz	 < 1.15:1 < 1.2:1 < 1.3:1 	3.84 MHz fil 5.0 MHz filt GSM Tx pov W-CDMA m
2200 to 2600 MHz	< 1.35:1	
Filters	1 kH z 30 kHz 100 kHz 300 kHz	Measurement Within cellular -59 to +35 d -65 to < -5 Within cellular
	640 kHz 1.23 MHz 1.6 MHz	self alignment –59 to +35 o –65 to < –59
	5.0 MHz GSM Tx power W-CDMA mean power	400 to 2000 M 59 to +35 o 65 to <59
Trigger setup		Measurement
Arm	Single, continuous	Returning to s
Delay (varies by filter and measurement)	–180 to 180 ms	Frequency
Sources (varies by measurement)	External, fall, immediate, rise	Measurement
Measurement setup Averaging (multi-measurement count–not applicable to all measurements)	Off, 1 to 999	-60 to +35 o with 1, 30, 1 300, 640 kH Tx power fill
Timeout	Off, 0.1 to 999.9 s	//0 to ±2⊑ /

RF Channel Suite

Includes channel power, frequency error, power versus time, and IQ capture measurements.

Input level range Average power	—65 to +35 dBm	
Measurement interval and filter	ranges	
1 kHz filter	1 to 5000 ms	
30 kHz filter	0.4 to 4000 ms	
100 kHz filter	0.1 to 4000 ms	
300 kHz filter	0.01 to 1700 ms	
640 kHz filter	0.01 to 810 ms	
1.23 MHz filter	0.01 to 420 ms	
1.6 MHz filter	0.01 to 320 ms	
3.84 MHz filter	0.01 to 135 ms	
5.0 MHz filter	0.01 to 100 ms	
GSM Tx power filter	0.01 to 199 ms	
W-CDMA mean power filter	0.1 to 3200 ms	
Channel power measure	ement	
Measurement accuracy ¹		
Within cellular frequency bands		
–59 to +35 dBm	$< \pm 0.6$ dB, typically $< \pm 0.3$ dB	
−65 to < −59 dBm	$< \pm 0.7$ dB, typically $< \pm 0.4$ dB	
Within cellular frequency bands self alignment initiated	with < 48 hours warm-up before	
–59 to +35 dBm	< ±0.7 dB, <i>typically</i> < ±0.3 dB	
–65 to < –59 dBm	$< \pm 0.8 \text{ dB}$, typically $< \pm 0.4 \text{ dB}$	
400 to 2000 MHz		
–59 to +35 dBm	Typically $< \pm 0.4 \ dB$	
–65 to < –59 dBm	Typically $< \pm 0.6 \ dB$	
Measurement repeatability	<i>Typically</i> < ±0.05 dB	
Returning to same level and freq	uency, no temperature change	
and insignificant time change		
Frequency error measurement		
Measurement accuracy CW signals from 400 to 2000 MH	łz	

-60 to +35 dBm $< \pm(50$ Hz + timebase accuracy)with 1, 30, 100,300, 640 kHz GSM300, 640 kHz GSM7x power filters-40 to +35 dBm $< \pm(50$ Hz + timebase accuracy)with 1.23, 3.84,5.0 MHz W-CDMAmean power filters

^{1.} Additional accuracy error when using RF OUT ONLY port is < ± 0.1 dB.

RF Channel Suite – continued

Power versus time measurement

This measurement is a graphical view of output power in the time domain. It is also useful as a zero-span spectrum analyzer.

Dynamic range (-15 dBm input signal)

With 1, 30, 100, 300, 640 kHz Typically > 64 dB GSM Tx power filters With 1.23, 3.84, 5.0 MHz Typically > 54 dB W-CDMA mean power filters

IQ capture measurement

This measurement returns the IQ samples collected during the most recent RF channel suite measurements in either rectangular or polar format. The collected samples are provided as real/imaginary number pairs in rectangular format, or as magnitude/phase pairs in polar format.

Measurement results

IQ samples Number of samples Sample period

QPSK EVM measurement

This measurement calculates QPSK composite EVM and several other results relating to UE modulation quality.

Input level range

Average power	-25 to +28 dBm/3.48 MHz
UE ranges	
EVM	≤ 25% rms
Frequency error	< ±10 kHz

Measurement accuracy (Includes residual results,

measured for one slot (0.666666667 ms) measurement interval)	
UE EVM 0% rms	< 2.5% rms
UE EVM 17.5% rms	< 0.7% rms
UE 25% rms	< 0.5% rms
Frequency error	< (±10 Hz + timebase accuracy)
Filter	5 MHz

offset

EVM, phase error, magnitude error, frequency error, origin

Filter

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Measurement results
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Spectrum Monitor

Input level range

Average power

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Absolute level accuracy¹

Within cellular frequency bands at expected frequency and level

-65 to +35 dBm

–59 to +35 dBm	$< \pm 0.6$ dB, typically $< \pm 0.3$ dB
–65 to < –59 dBm	$< \pm 0.7$ dB, typically $< \pm 0.4$ dB

Within cellular frequency bands at expected frequency and level with < 48 hours warm-up before self alignment initiated

-59 to +35 dBm	$< \pm 0.7$ dB, typically $< \pm 0.3$ dB
-65 to <59 dBm	$<\pm0.8$ dB, typically $<\pm0.4$ dB

380 to 2000 MHz at expected frequency and level

–59 to +35 dBm	Typically < ±0.4 dB
–65 to < –59 dBm	Typically < ±0.6 dB
Absolute level flatness	Typically < ±0.15 dB

Spurious response Typically < -65 dBc Signals ≥ -10 dBm excluding spurs that change with input

attenuation but not with input level

Resolution bandwidth (RBW)	3 kHz to 5 MHz
Span	RBW to 25 MHz
Amplitude scaling	0.1 to 20 dB/division
Markers	
Number	0 to 5
Frequency	Absolute, relative
Amplitude	Absolute, relative

^{1.} Additional accuracy error when using RF OUT ONLY port is $< \pm 0.1$ dB.

Internal OCXO Timebase

Output level range	Typically 0 to +10 dBm
Aging rate	< ±0.1 ppm/year
Temperature stability (referenced to +25 °C) -10 to +70 °C < ±0.05 ppm	
Accuracy After 30-minute warm-up	±[time since last calibration x aging rate + temperature stability + accuracy of calibration]
Initial adjustment	±0.05 ppm
Locking range	<i>Typically</i> ±0.2 <i>ppm</i>
Output frequency	10 MHz + locking range
Output impedance	Typically 50 ohms

Synchronization Inputs/Outputs

External reference input

ypically ±0.2 ppm
, 2, 5, or 10 MHz ± locking range
ypically 0 to +10 dBm
pically 50 ohms

Baseband triggers

Rear-panel input and/or output connections for format-dependent synchronization with external equipment.

Bi-directional DB9 connector	5 TTL triggers
Input BNC connector	1 TTL trigger input
Output BNC connector	1 TTL trigger output

General Specifications

Operating temper	ature range	+10 to +55 °C
Storage temperat	ure range	–20 to +65 °C
Dimensions H × V	V x D	8.75 x 16.75 x 21 inches 222 x 426 x 533 mm
Weight		51 pounds 23.1 kg
AC power input		100 to 240 VAC, 50 to 60 Hz
AC power consun	nption	Typically 260 W maximum
Calibration interv	al	2 years
Self alignment co User alerted tha self re-alignmer and can choose then or to ignor	nditions at automatic nt is required to align e until later	 ±10 °C from last self alignment, or > 24 hours since last RF generator self alignment or > 30 days since last instrument self alignment
Self alignment tin	nes	
RF generator		Typically < 1 minute
Instrument and	RF generator	<i>Typically < 5 minutes</i>
EMC Meets standard	s as listed	IEC 61326:2002 / EN 61326:1997 + A1:1998 + A2:2000 + A3:2003
Canada		ICES-001:2004
Australia and N	ew Zealand	AS/NZS CISPR11:2002
Safaty		
Meets standard	s as listed	IEC 61010-1:2001 / EN 61010-1:2001
Canada		CSA C22.2 No. 61010-1:2004
USA		UL 61010-1:2004
Radiated source I Within cellular bands, at zero s 10 Hz resolutior and one inch (2 instrument fron from front half o instrument surf	eakage frequency pan with bandwidth .54 cm) from t panel and of all sides of aces	Typically < 1 μV rms
Remote programm	ning	
GPIB LAN USB-B		IEEE standard 488.2 1 RJ45 rear-panel connector 1 rear-panel connector
External device co	onnections	
USB-A		2 front-panel USB 1.1 4 rear-panel USB 2.0

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